**Preferred Device** 

# **General Purpose Transistors**

# **PNP Silicon**



Rating	Symbol	Value	Unit
Collector-Emitter Voltage	VCEO	40	Vdc
Collector-Base Voltage	VCBO	40	Vdc
Emitter–Base Voltage	V <sub>EBO</sub>	5.0	Vdc
Collector Current – Continuous	IC	200	mAdc
Total Device Dissipation  @ T <sub>A</sub> = 25°C  Derate above 25°C	PD	625 5.0	mW mW/°C
Total Power Dissipation @ T <sub>A</sub> = 60°C	PD	250	mW
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	1.5 12	Watts mW/°C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C

### THERMAL CHARACTERISTICS (Note 1.)

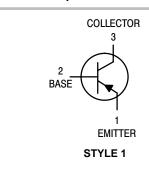
Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	$R_{ heta JA}$	200	°C/W
Thermal Resistance, Junction to Case	R <sub>θ</sub> JC	83.3	°C/W

1. Indicates Data in addition to JEDEC Requirements.



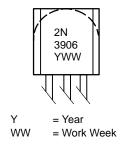
## ON Semiconductor™

#### http://onsemi.com





#### **MARKING DIAGRAMS**



#### **ORDERING INFORMATION**

Device	Package	Shipping
2N3906	TO-92	5000 Units/Box
2N3906RLRA	TO-92	2000/Tape & Reel
2N3906RLRE	TO-92	2000/Tape & Reel
2N3906RLRM	TO-92	2000/Ammo Pack
2N3906RLRP	TO-92	2000/Ammo Pack
2N3906RL1	TO-92	2000/Tape & Reel
2N3906ZL1	TO-92	2000/Ammo Pack

**Preferred** devices are recommended choices for future use and best overall value.

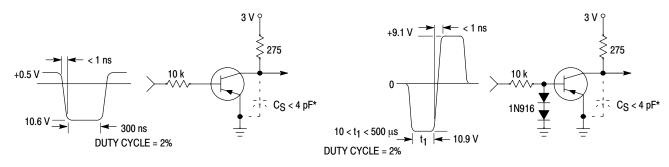
#### 2N3906

## **ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

	Characteristic	Symbol	Min	Max	Unit
OFF CHARACTE	RISTICS			•	
Collector-Emitter I	Breakdown Voltage (Note 2.) (I <sub>C</sub> = 1.0 mAdc, I <sub>B</sub> = 0)	V <sub>(BR)</sub> CEO	40	_	Vdc
Collector-Base Br	eakdown Voltage (I <sub>C</sub> = 10 μAdc, I <sub>E</sub> = 0)	V <sub>(BR)</sub> CBO	40	-	Vdc
Emitter-Base Brea	akdown Voltage (I <sub>E</sub> = 10 μAdc, I <sub>C</sub> = 0)	V <sub>(BR)EBO</sub>	5.0	_	Vdc
Base Cutoff Currer	nt (V <sub>CE</sub> = 30 Vdc, V <sub>EB</sub> = 3.0 Vdc)	I <sub>BL</sub>	_	50	nAdc
Collector Cutoff Cu	urrent (V <sub>CE</sub> = 30 Vdc, V <sub>EB</sub> = 3.0 Vdc)	ICEX	_	50	nAdc
ON CHARACTER	RISTICS (Note 2.)	1		•	·I
DC Current Gain  (IC = 0.1 mAdc, $V_{CE} = 1.0 \text{ Vdc}$ )  (IC = 1.0 mAdc, $V_{CE} = 1.0 \text{ Vdc}$ )  (IC = 10 mAdc, $V_{CE} = 1.0 \text{ Vdc}$ )  (IC = 50 mAdc, $V_{CE} = 1.0 \text{ Vdc}$ )  (IC = 100 mAdc, $V_{CE} = 1.0 \text{ Vdc}$ )		hFE	60 80 100 60 30	- 300 - -	_
Collector–Emitter Saturation Voltage (I <sub>C</sub> = 10 mAdc, I <sub>B</sub> = 1.0 mAdc) (I <sub>C</sub> = 50 mAdc, I <sub>B</sub> = 5.0 mAdc		VCE(sat)	- -	0.25 0.4	Vdc
Base–Emitter Saturation Voltage ( $I_C = 10 \text{ mAdc}$ , $I_B = 1.0 \text{ mAdc}$ ) ( $I_C = 50 \text{ mAdc}$ , $I_B = 5.0 \text{ mAdc}$ )		VBE(sat)	0.65 -	0.85 0.95	Vdc
SMALL-SIGNAL	CHARACTERISTICS				
Current-Gain - Bandwidth Product (I <sub>C</sub> = 10 mAdc, V <sub>CE</sub> = 20 Vdc, f = 100 MHz)		fT	250	_	MHz
Output Capacitano	e ( $V_{CB} = 5.0 \text{ Vdc}$ , $I_{E} = 0$ , $f = 1.0 \text{ MHz}$ )	C <sub>obo</sub>	_	4.5	pF
Input Capacitance (VEB = 0.5 Vdc, IC = 0, f = 1.0 MHz)		C <sub>ibo</sub>	_	10	pF
Input Impedance (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 10 Vdc, f = 1.0 kHz)		h <sub>ie</sub>	2.0	12	kΩ
Voltage Feedback Ratio (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 10 Vdc, f = 1.0 kHz)		h <sub>re</sub>	0.1	10	X 10 <sup>-4</sup>
Small–Signal Current Gain (IC = 1.0 mAdc, VCE = 10 Vdc, f = 1.0 kHz)		h <sub>fe</sub>	100	400	-
Output Admittance (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 10 Vdc, f = 1.0 kHz)		h <sub>oe</sub>	3.0	60	μmhos
Noise Figure (I <sub>C</sub> = 100 $\mu$ Adc, V <sub>CE</sub> = 5.0 Vdc, R <sub>S</sub> = 1.0 k $\Omega$ , f = 1.0 kHz)		NF	_	4.0	dB
SWITCHING CHA	ARACTERISTICS			•	•
Delay Time	(V <sub>CC</sub> = 3.0 Vdc, V <sub>BE</sub> = 0.5 Vdc,	t <sub>d</sub>	_	35	ns
Rise Time	I <sub>C</sub> = 10 mAdc, I <sub>B1</sub> = 1.0 mAdc)	t <sub>r</sub>	_	35	ns
Storage Time	$(V_{CC} = 3.0 \text{ Vdc}, I_{C} = 10 \text{ mAdc}, I_{B1} = I_{B2} = 1.0 \text{ mAdc})$	t <sub>S</sub>	_	225	ns
Fall Time	$(V_{CC} = 3.0 \text{ Vdc}, I_{C} = 10 \text{ mAdc}, I_{B1} = I_{B2} = 1.0 \text{ mAdc})$	t <sub>f</sub>	_	75	ns

IB1 = IB2 = 1.0 mAdc)

2. Pulse Test: Pulse Width  $\leq$  300 µs; Duty Cycle  $\leq$  2%.

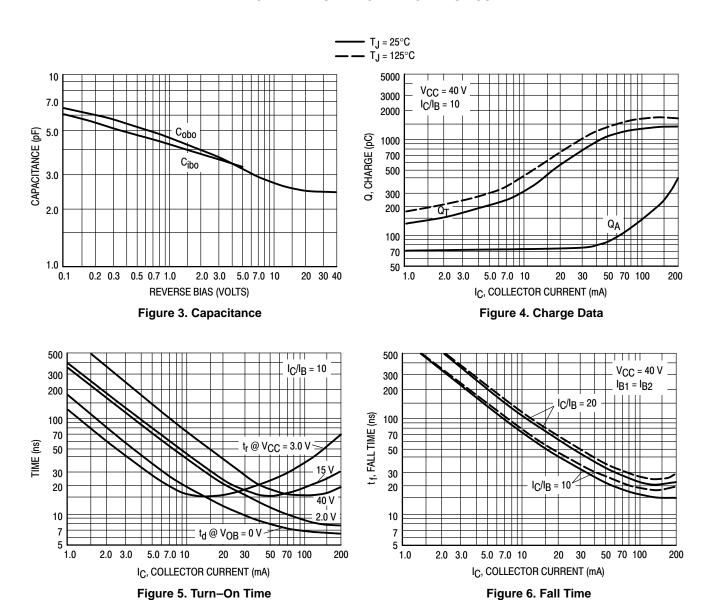


\* Total shunt capacitance of test jig and connectors

Figure 1. Delay and Rise Time Equivalent Test Circuit

Figure 2. Storage and Fall Time Equivalent Test Circuit

#### TYPICAL TRANSIENT CHARACTERISTICS



http://onsemi.com

# TYPICAL AUDIO SMALL-SIGNAL CHARACTERISTICS NOISE FIGURE VARIATIONS

 $(V_{CE} = -5.0 \text{ Vdc}, T_A = 25^{\circ}\text{C}, Bandwidth} = 1.0 \text{ Hz})$ 

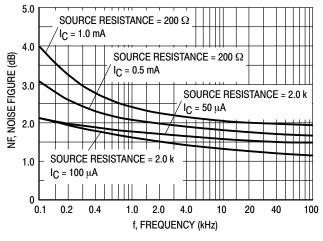
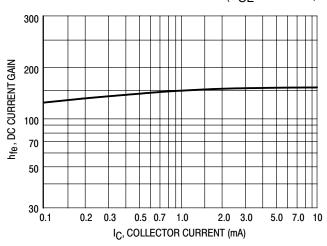


Figure 7.

Figure 8.

#### h PARAMETERS

 $(V_{CE} = -10 \text{ Vdc}, f = 1.0 \text{ kHz}, T_A = 25^{\circ}\text{C})$ 



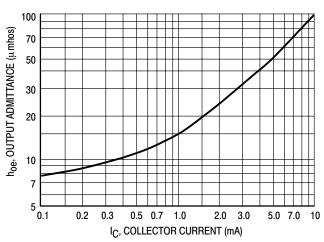
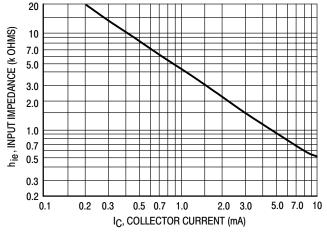


Figure 9. Current Gain

Figure 10. Output Admittance



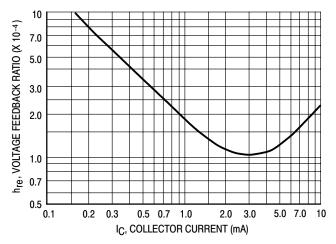


Figure 11. Input Impedance

Figure 12. Voltage Feedback Ratio

#### TYPICAL STATIC CHARACTERISTICS

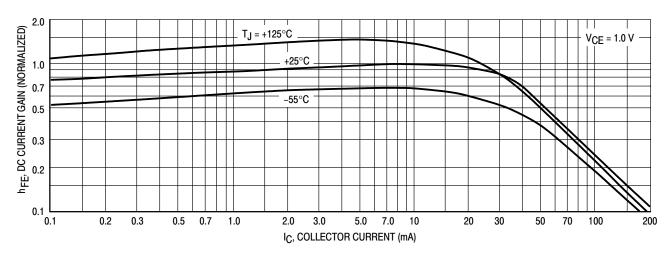


Figure 13. DC Current Gain

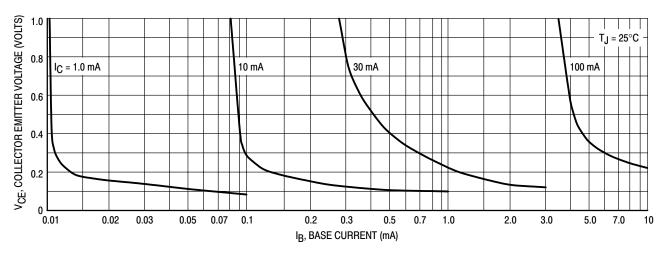


Figure 14. Collector Saturation Region

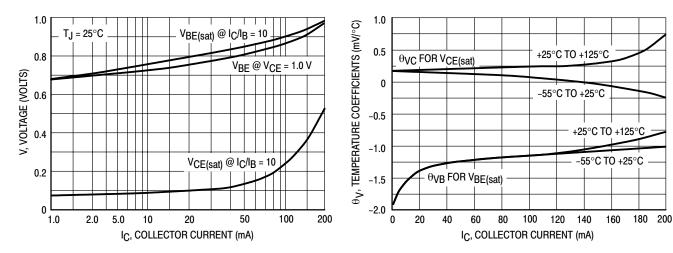


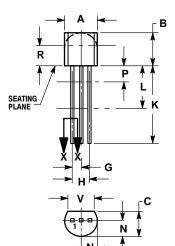
Figure 15. "ON" Voltages

Figure 16. Temperature Coefficients

### 2N3906

#### **PACKAGE DIMENSIONS**

#### TO-92 **TO-226AA** CASE 29-11 **ISSUE AL**





- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. CONTOUR OF PACKAGE BEYOND DIMENSION R IS UNCONTROLLED.
  4. LEAD DIMENSION IS UNCONTROLLED IN P AND BEYOND DIMENSION K MINIMUM.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.175	0.205	4.45	5.20
В	0.170	0.210	4.32	5.33
С	0.125	0.165	3.18	4.19
D	0.016	0.021	0.407	0.533
G	0.045	0.055	1.15	1.39
Н	0.095	0.105	2.42	2.66
J	0.015	0.020	0.39	0.50
K	0.500		12.70	
L	0.250		6.35	
N	0.080	0.105	2.04	2.66
Р		0.100		2.54
R	0.115		2.93	
V	0 135		3 43	

STYLE 1:
PIN 1. EMITTER
2. BASE
3. COLLECTOR

STYLE 14:
PIN 1. EMITTER
2. COLLECTOR
3. BASE

## 2N3906

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